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|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/598,961 | | Applicant(s)/Patent Under Reexamination WATANABE ET AL. | |
| | Examiner Savitri Mulpuri | | Art Unit 2812 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-6,461,937 | 10-2002 | Kim et al. | 438/431 |
| * | B | US-6,436,790 | 08-2002 | Ito, Shinya | 438/424 |
| * | C | US-6,368,931 | 04-2002 | Kuhn et al. | 438/359 |
| * | D | US-2007/0087567 | 04-2007 | Lee et al. | 438/687 |
| * | E | US-7,052,970 | 05-2006 | Radecker, Joerg | 438/435 |
| * | F | US-6,955,974 | 10-2005 | Lee et al. | 438/437 |
| * | G | US-2005/0037613 | 02-2005 | Grunow et al. | 438/643 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | I | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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